

1200V N-Channel MOSFET

FEATURES

- Low On-Resistance
- Low Capacitance
- Avalanche Ruggedness
- Halogen Free, RoHS Compliant

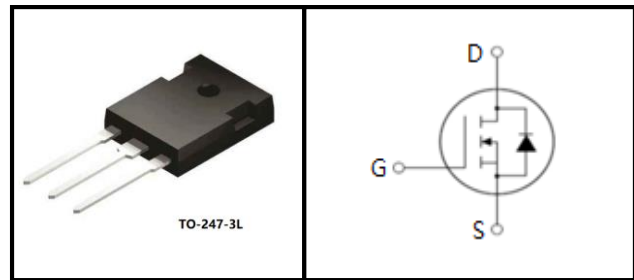
BENEFITS

- Higher System Efficiency
- Parallel Device Convenience
- High Temperature Application
- High Frequency Operation



APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- Uninterruptible Power Supply (UPS)
- EV Charging station & Motor Drives
- Solar/ Wind Renewable Energy
- Power Inverters & DC/DC Converters



Device Marking and Package Information		
Device	Package	Marking
C2M120W080	TO-247-3L	C2M120W080

Absolute Maximum Ratings $T_C = 25^\circ\text{C}$, unless otherwise noted				
Parameter	Symbol	Test Conditions	Value	Unit
Drain-Source Voltage	V_{DSS}	$V_{GS}=0V, I_{DS}=100\mu A$	1200	V
Continuous Drain Current	I_D	$V_{GS}=20V, T_C=25^\circ C$	36	A
		$V_{GS}=20V, T_C=110^\circ C$	22	
Pulsed Drain Current	I_{DM}	t_{pw} limitation per Fig.17	138	
Single Pulse Avalanche Energy	E_{AS}	$V_{DD}=100V, I_D=10A$	1250	mJ
Power Dissipation	P_D	$T_C=25^\circ C$	208	W
Recommend Gate Source Voltage	$V_{GS, op}$		-5/+20	V
Maximum Gate Source Voltage	$V_{GS, max}$		-10/+25	
Soldering Temperature	T_L		260	$^\circ\text{C}$
Operating Junction and Storage Temperature Range	T_J, T_{stg}		-55/+150	

Specifications $T_J = 25^\circ\text{C}$, unless otherwise noted						
Parameter	Symbol	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
Static						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 100\mu A$	1200	--	--	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 1200V, V_{GS} = 0V, T_J = 25^\circ\text{C}$	--	<1	50	μA
		$V_{DS} = 1200V, V_{GS} = 0V, T_J = 150^\circ\text{C}$	--	5	200	
Gate-Source Leakage	I_{GSS}	$V_{GS} = 20V, V_{DS} = 0V$	--	--	250	nA
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = 10V, I_D = 10mA$	--	2.4	--	V
Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = 20V, I_D = 18A$	--	80	96	m Ω
		$V_{GS} = 20V, I_D = 18A, T_J = 150^\circ\text{C}$	--	105	--	
Dynamic						
Input Capacitance	C_{iss}	$V_{GS} = 0V,$ $V_{DS} = 800V,$ $f = 1.0MHz$ $V_{AC}=25mV$	--	1303	--	pF
Output Capacitance	C_{oss}		--	367	--	
Reverse Transfer Capacitance	C_{rss}		--	53	--	
Effective Output Capacitance, Energy Related	$C_{o(er)}$		$V_{GS}=0V,$ $V_{DS}=0 \text{ to } 800V$	--	131	
Effective Output Capacitance, Time Related	$C_{o(tr)}$	$I_D=const., V_{GS}=0V,$ $V_{DS}=0 \text{ to } 800V$	--	180	--	
Total Gate Charge	Q_g	$V_{DD} = 800V,$ $I_D = 18A,$ $V_{GS} = -5 \text{ to } 20V$	--	96	--	nC
Gate-Source Charge	Q_{gs}		--	15	--	
Gate-Drain Charge	Q_{gd}		--	45	--	
Gate plateau voltage	V_{pl}		--	11.2	--	V
Turn-on Delay Time	$t_{d(on)}$	$V_{DS}=800V,$ $V_{GS}=-4/20V, I_D=18A,$ $R_L=40\Omega,$ $R_{G(ext)}= 2.7 \Omega$	--	55.5	--	ns
Turn-on Rise Time	t_r		--	153	--	
Turn-off Delay Time	$t_{d(off)}$		--	112	--	
Turn-off Fall Time	t_f		--	91	--	
Coss Stored Energy	E_{oss}	$V_{GS}=0V, V_{DS}=800V$ $f=1MHz, V_{AC}=25mV$	--	58*	--	μJ
Turn-on Switching Energy	E_{on}	$V_{DS}=800V,$ $V_{GS}=0/20V, I_D=18A,$ $R_{G(ext)}= 2.7 \Omega$	--	115*	--	
Turn-off Switching Energy	E_{off}		--	165*	--	
Internal Gate Resistance	$R_{G(int.)}$	$f=1MHz, V_{AC}=25mV$	--	5.6	--	Ω

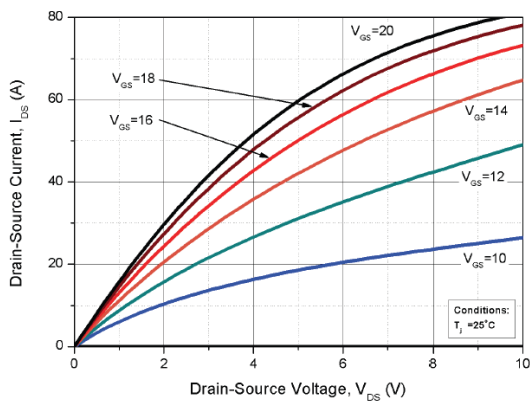
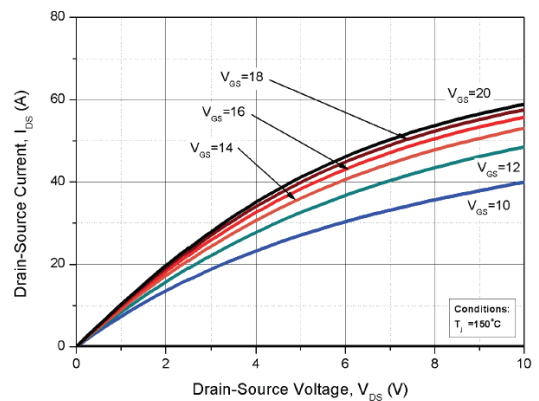
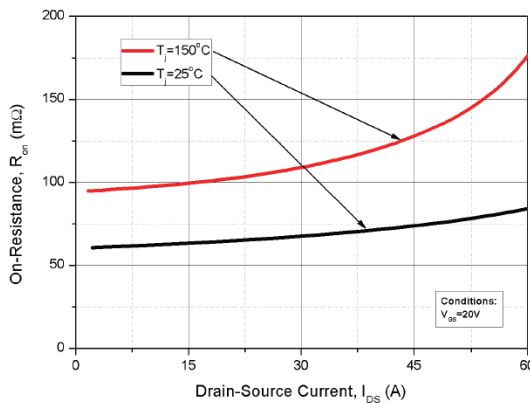
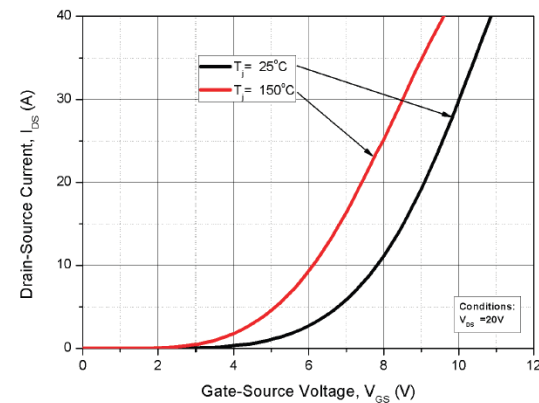
*The energy loss caused by the reverse recovery of FWD is not included in E_{on} .

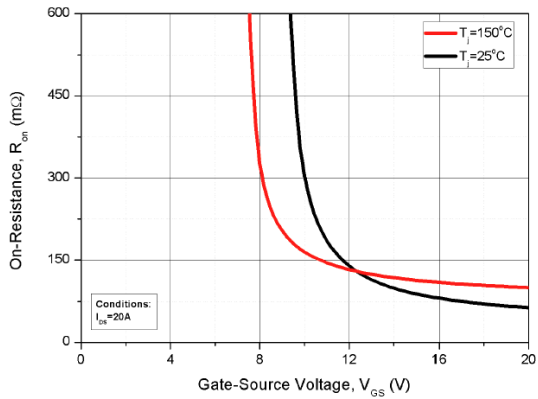
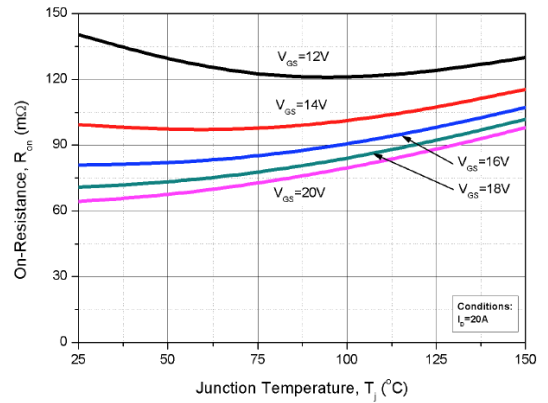
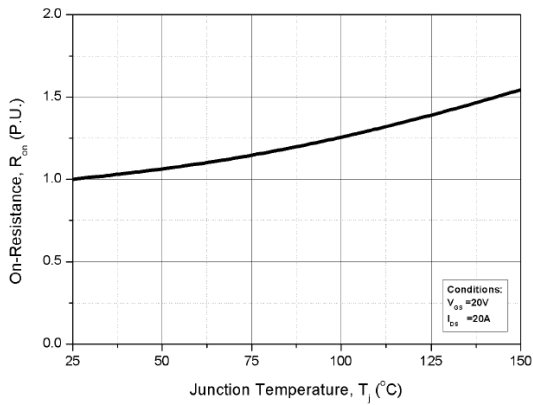
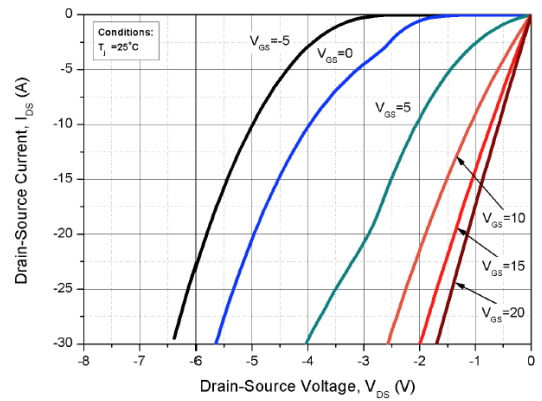
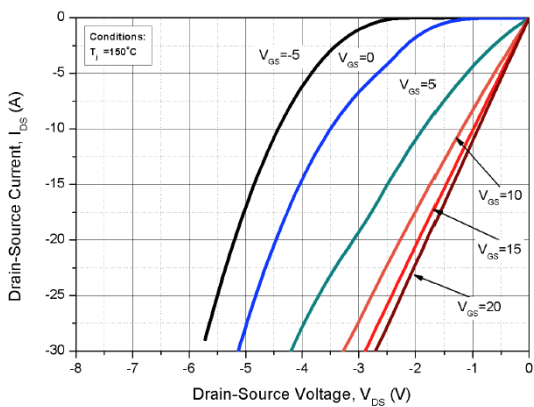
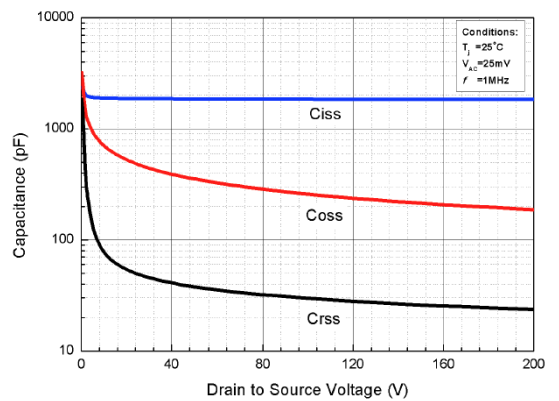
Specifications $T_J = 25^\circ\text{C}$, unless otherwise noted

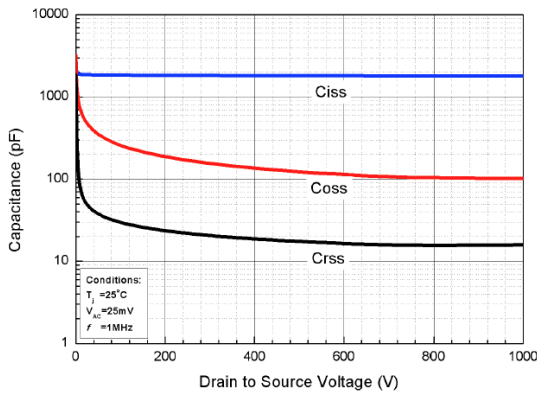
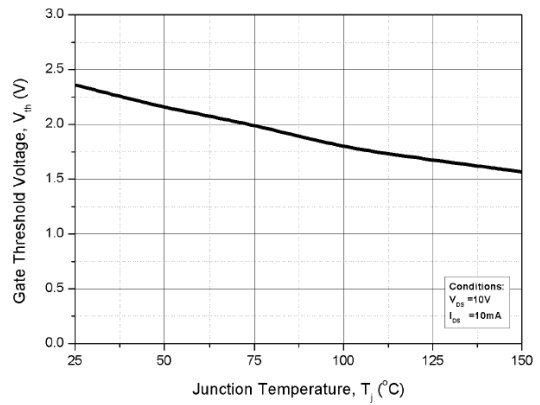
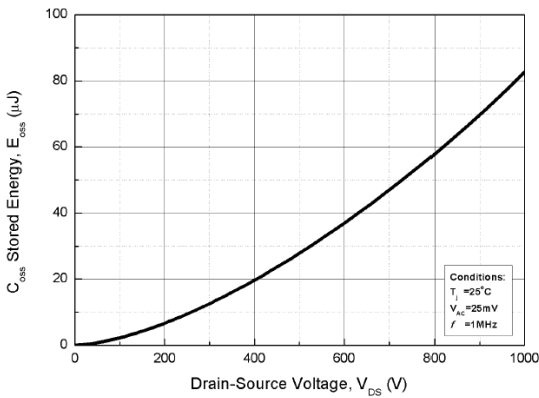
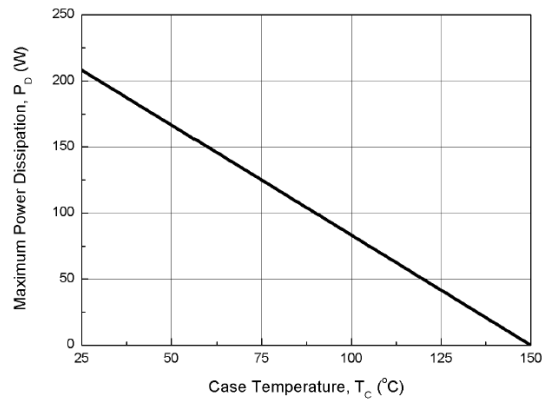
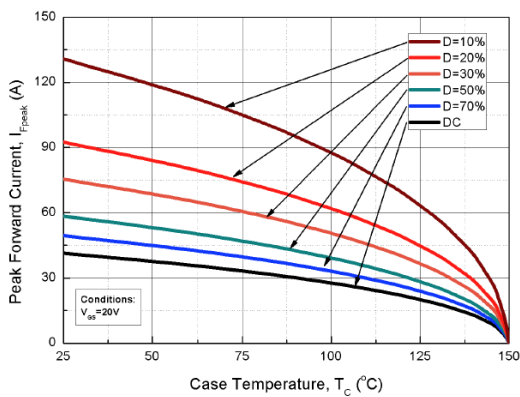
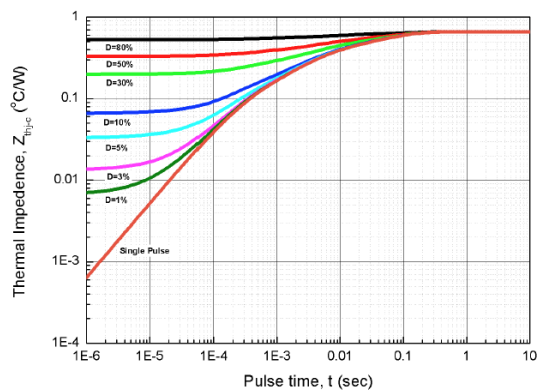
Parameter	Symbol	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
Built-in SiC Diode Characteristics						
Continuous Diode Forward Current	I_S	$V_{GS} = -5\text{V}$, $T_C = 25^\circ\text{C}$	--	33	--	A
Inverse Diode Forward Voltage	V_{SD}	$I_S = 10.8\text{A}$, $V_{GS} = -5\text{V}$	--	5.4	--	V
Reverse Recovery Time	t_{rr}	$V_{GS} = 0\text{V}$, $I_F = 18\text{A}$, $V_{DS} = 800\text{V}$, $di_F/dt = 300\text{A}/\mu\text{s}$	--	40	--	ns
Reverse Recovery Charge	Q_{rr}		--	43	--	nC
Peak Reverse Recovery Current	I_{rrm}		--	1.8	--	A

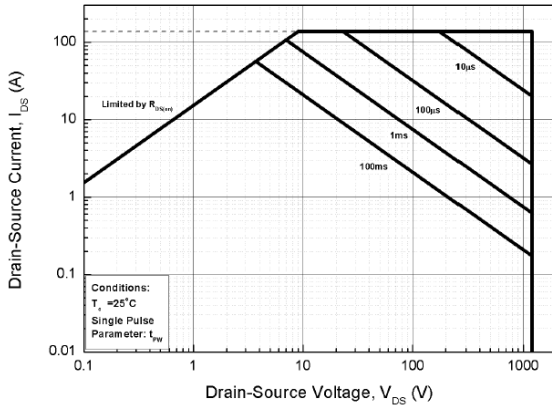
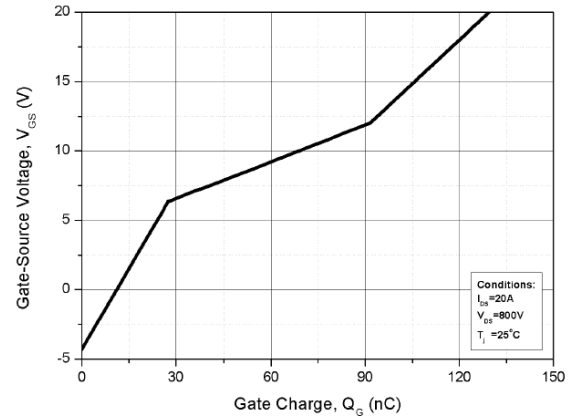
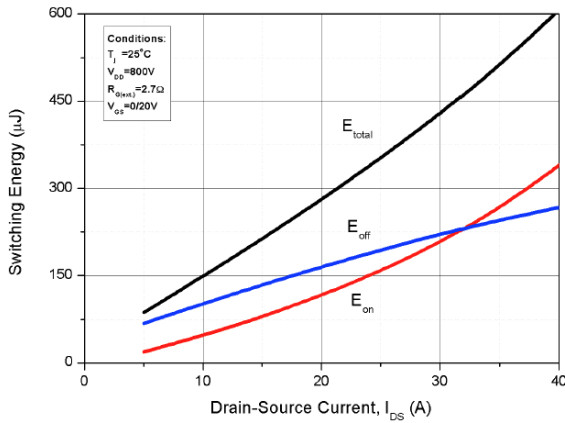
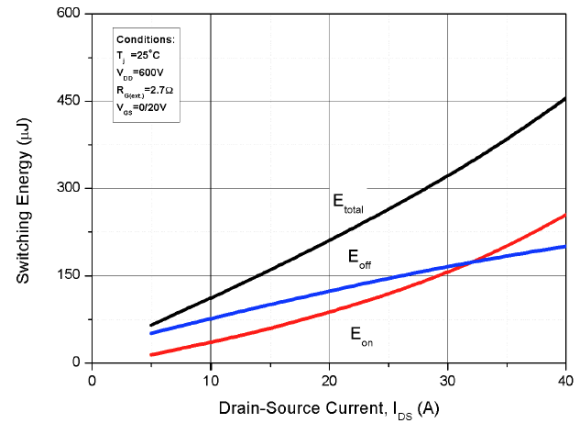
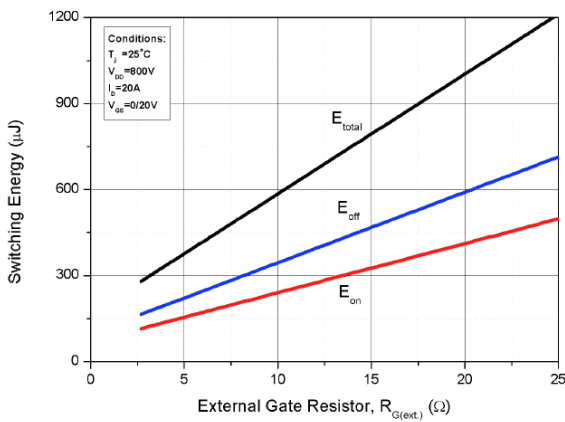
Thermal Resistance

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	R_{thJC}	0.6	K/W

Typical Device Performance

Fig. 1 Forward Output Characteristics at $T_j = 25^\circ\text{C}$

Fig. 2 Forward Output Characteristics at $T_j = 150^\circ\text{C}$

Fig. 3 On-Resistance vs. Drain Current for Various T_j

Fig. 4 Transfer Characteristics for Various T_j

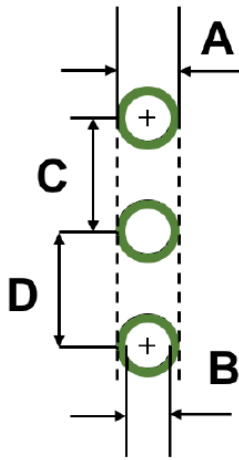
Typical Device Performance

Fig. 5 On-Resistance vs. Gate Voltage for Various T_j

Fig. 6 On-Resistance vs. Temperature for Various Gate Voltage

Fig. 7 Normalized On-Resistance vs. Temperature

Fig. 8 Reverse Output Characteristics at $T_j = 25^\circ\text{C}$

Fig. 9 Reverse Output Characteristics at $T_j = 150^\circ\text{C}$

Fig. 10 Capacitances vs. Drain to Source Voltage (0 - 200V)


Fig. 11 Capacitances vs. Drain to Source Voltage (0 - 1000V)

Fig. 12 Threshold Voltage vs. Temperature

Fig. 13 Output Capacitor Stored Energy*

Fig. 14 Maximum Power Dissipation Derating vs. Case Temperature

Fig. 15 Drain Current Derating vs. Case Temperature

Fig. 16 Transient Junction to Case Thermal Impedance

Typical Device Performance

Fig. 17 Safe Operating Area

Fig. 18 Gate Charge Characteristics

Fig. 19 Clamped Inductive Switching Energy vs. Drain Current ($V_{DD}=800V$)*

Fig. 20 Clamped Inductive Switching Energy vs. Drain Current ($V_{DD}=600V$)*

Fig. 21 Clamped Inductive Switching Energy vs. External Gate Resistor ($R_{G(ext.)}$)*

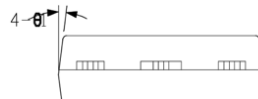
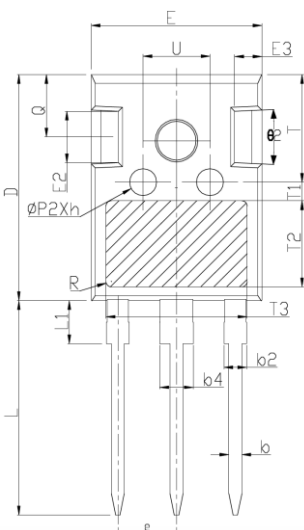
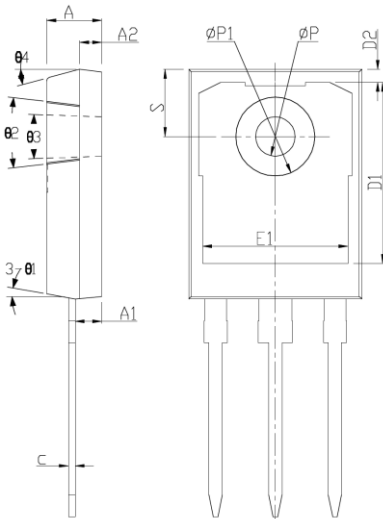
*Base on the results of calculation, note that the energy loss caused by the reverse recovery of FWD is not included in E_{on} .

Recommended Solder Pad Layout (TO-247-3L)



Mechanical Parameters			
Parameter	Symbol	Typical	Unit
Length	A	3.048	mm
	B	2.032	
	C	5.436	
	D	5.436	

Mechanical Parameters



NOTES:
 1. All dimensions are in mm.
 2. Tolerance: $\pm 0.05\text{mm}$.

SYMBOL	DIMENSIONS IN MILLIMETERS		
	MIN	NOM	MAX
A	4.75	5.00	5.25
A1	2.16	2.41	2.66
A2	1.85	2.00	2.15
b	1.11	1.21	1.35
b2	1.90	2.01	2.25
b4	2.90	3.01	3.25
c	0.51	0.61	0.75
D	20.60	21.00	21.40
D1	16.15	16.55	16.95
D2	1.00	1.20	1.40
E	15.50	15.80	16.10
E1	13.00	13.30	13.60
E2	4.70	5.00	5.30
E3	2.25	2.50	2.75
e	5.44BSC		
h	0.00	0.10	0.25
L	19.52	19.92	20.32
L1	-	-	4.30
ΦP	3.35	3.60	3.85
$\Phi P1$	-	-	7.30
$\Phi P2$	2.25	2.50	2.75
Q	5.50	5.80	6.10
S	6.15BSC		
R	0.50REF		
T	9.70	-	10.30
T1	1.65REF		
T2	8.00REF		
T3	12.80REF		
U	5.90	-	6.50
$\theta 1$	4°	7°	10°
$\theta 2$	2°	5°	8°
$\theta 3$	1°	-	2°
$\theta 4$	10°	15°	20°

*The information provided herein is subject to change without notice.

Disclaimer

All product specifications and data are subject to change without notice.

For documents and material available from this datasheet, Suzhou Convert does not warrant or assume any legal liability or responsibility for the accuracy, completeness of any product or technology disclosed hereunder.

No license, express or implied, by estoppels or otherwise, to any intellectual property rights is granted by this document or by any conduct of Suzhou Convert.

The products shown herein are not designed for use in medical, life-saving, or life-sustaining applications unless. Customers using or selling Suzhou Convert products not expressly indicated for use in such applications do so entirely at their own risk and agree to fully indemnify Suzhou Convert for any damages arising or resulting from such use or sale.

Suzhou Convert disclaims any and all liability arising out of the use or application of any product described herein or of any information provided herein to the maximum extent permitted by law. The product specifications do not expand or otherwise modify Suzhou Convert's terms and conditions of purchase, including but not limited to the warranty expressed therein, which apply to these products.

Suzhou Convert Semiconductor CO., Ltd. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.

In the event that any or all Suzhou Convert products(including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.

Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. Suzhou Convert believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.